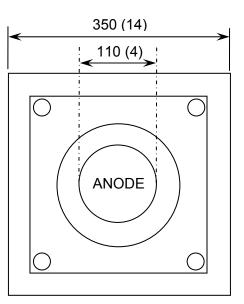
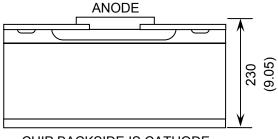
100V 0.3A Fast Switching Diode - 1N4448

Small-Signal high speed switching diode in bare die form

Die Dimensions in µm (mils)





CHIP BACKSIDE IS CATHODE

Mechanical Specification

Die Size (Unsawn)	350 x 350 13.78 x 13.78	µm mils	
Anode Pad Size	110 Ø 4.33 Ø	µm mils	
Die Thickness	230 (±15) 9.05 (±0.59)	µm mils	
Top Metal Composition	AI		
Back Metal Composition	AuAs		

Features:

- Fast Switching Speed
- High conductance
- General purpose switching applications
- High reliability tested grades.

Ordering Information

The following part suffixes apply:

- No suffix MIL-STD-750 /2073 Visual Inspection
- "H" MIL-STD-750 /2073 Visual Inspection + MIL-PRF-38534 Class H LAT
- "K" MIL-STD-750 /2073 Visual Inspection + MIL-PRF-38534 Class K LAT

LAT = Lot Acceptance Test.

For further information on LAT process flows see below.

www.siliconsupplies.com\quality\bare-die-lot-qualification

Supply Formats:

- Default Die in Waffle Pack (400 per tray capacity)
- Sawn Wafer on Tape By specific request
- Unsawn Wafer By specific request
- Die Thickness <> 230µm(9 Mils) On request
- With additional electrical selection On request





100V 0.3A Fast Switching Diode - 1N4448

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Absolute Maximum Ratings	$I_{J} = 25^{\circ}C$ unless otherwise stated
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PARAMETER	SYMBOL	VALUE		UNIT		
	OTMEDE	VALUE	VALUE			
Non-repetitive Peak Reverse Voltage	V _{RSM}	105	105		105 V	
Repetitive Peak Reverse Voltage	V _{RRM}	100		V		
Average Rectified Forward Current	lo	200		mA		
DC Forward Current	I _F	300		mA		
Recurrent Peak Forward Current	l _f	400		mA		
Non-repetitive	I _{FSM}	Pulse width 1s	1	Α		
Peak forward surge current		Pulse width 1µs	4			
Power Dissipation	PD	200		mW		
Operating Junction temperature	TJ	-55 to 175		С°С		
Storage Temperature Range	T _{STG}	-65 to 200		C°		

1. Operation above the absolute maximum rating may cause device failure. Operation at the absolute maximum ratings, for extended periods, may reduce device reliability.

Electrical Characteristics T_J = 25°C unless otherwise stated

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNIT
Breakdown Voltage	V _R	I _R = 100μΑ	100	-	-	V
	VR	I _R = 5μΑ	75	-	-	V
Forward Voltage ²		I _F = 5mA	-	-	0.72	V
	VF	I _F = 20mA	-	-	1	
		I _F = 100mA	-	-	1	
Reverse Leakage I _R		V _R = 20V	-	-	0.025	μΑ
		V _R = 20V, T _J = 150°C	-	-	50	
	IR [V _R = 75V	-	-	5	
		V _R = 100V	V _R = 100V	-	-	10
Total Capacitance	CT	$V_R = 0V, f = 1MHz$	-	-	2	pF
Reverse Recovery Time	trr	I_F = 10mA, V_R = 6V (600mA) I_{rr} = 1mA, R_L = 100 Ω	-	-	4	ns

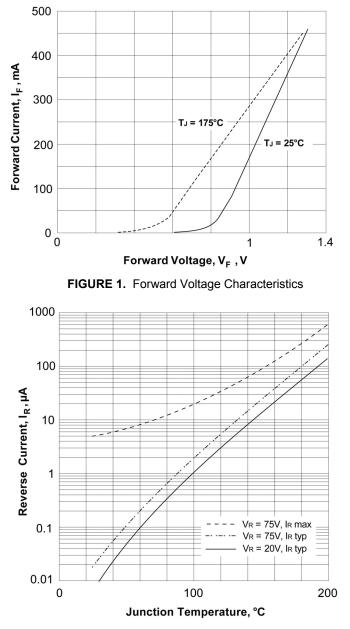
2. Pulse Width = 8.3ms, Non-recurrent square wave





Typical Characteristics T_J = 25°C unless otherwise stated

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